TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

2 S C 3 1 2 5

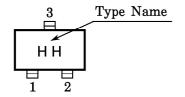
TV FINAL PICTURE IF AMPLIFIER APPLICATIONS

Good Lineality of f_T

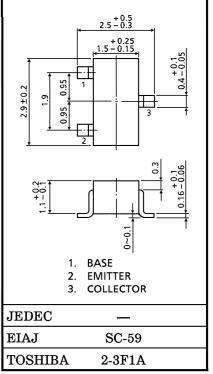
MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	v_{CBO}	30	V
Collector-Emitter Voltage	v_{CEO}	25	V
Emitter-Base Voltage	$V_{ m EBO}$	4	V
Collector Current	$I_{\mathbf{C}}$	50	mA
Base Current	$I_{\mathbf{B}}$	25	mA
Collector Power Dissipation	$P_{\mathbf{C}}$	150	mW
Junction Temperature	T_{j}	125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	°C

Marking



Unit in mm

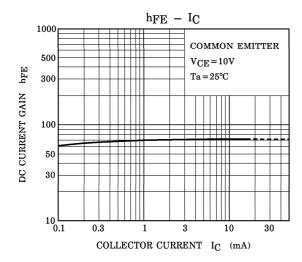


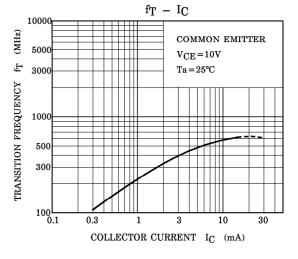
Weight: 0.012g

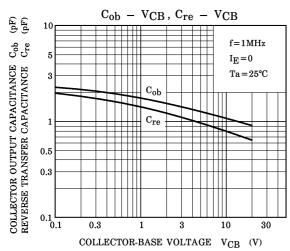
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

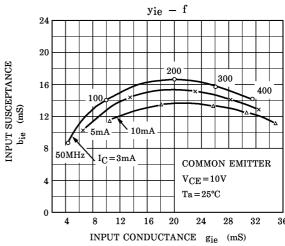
CHAR	ACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector C	ut-off Current	I_{CBO}	$V_{CB} = 30V, I_{E} = 0$	_	_	0.1	μ A
Emitter Cu	t-off Current	$I_{ m EBO}$	$V_{EB}=3V, I_{C}=0$	_	_	0.1	μ A
Collector-Er Breakdown		V _(BR) CEO	$I_{\rm C} = 10$ mA, $I_{\rm B} = 0$	25	_	_	V
DC Current	t Gain	$h_{ ext{FE}}$	$V_{CE} = 10V, I_{C} = 10mA$	20	70	200	_
Saturation	Collector-Emitter	V _{CE} (sat)	Ta = 15 m A T = = 15 m A	_	_	0.2	V
Voltage	Base-Emitter	V _{BE} (sat)	$I_{C}=15$ mA, $I_{B}=1.5$ mA	_	_	1.5	·
Collector O	utput Capacitance	C_{ob}	$V_{CB} = 10V, I_{E} = 0, f = 1MHz$	_	1.1	1.6	pF
Collector-Base Time Constant		C_{c} . rbb '	V_{CB} =10V, I_{C} =1mA, f=30MHz	_		25	ps
Transition 1	Frequency	$ m f_{T}$	$V_{CE} = 10V, I_{C} = 10mA$	250	600		MHz

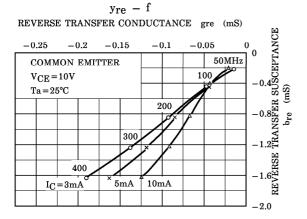
1 2001-05-31

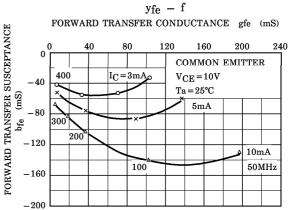




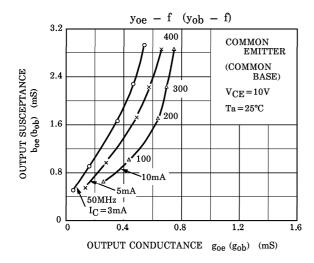


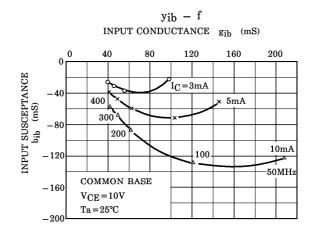


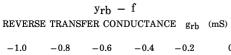


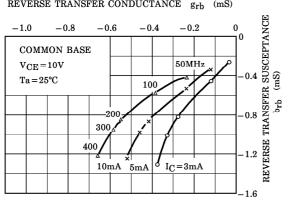


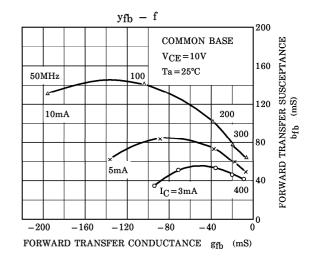
2 2001-05-31

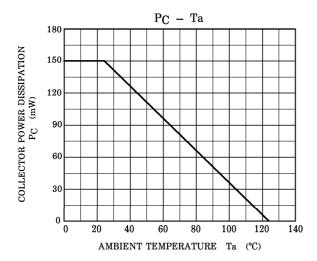












3 2001-05-31

RESTRICTIONS ON PRODUCT USE

000707EAA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.